

<b>Notice of References Cited</b>	Application/Control No. 10/705,174		Applicant(s)/Patent Under Reexamination MITCHELL ET AL.	
	Examiner Yoon-Young Kim		Art Unit 1723	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,827,854 B2	12-2004	Mitchell et al.	210/263
*	B	US-6,565,749 B1	05-2003	Hou et al.	210/500.38
*	C	US-6,660,166 B2	12-2003	Tremblay et al.	210/694
*	D	US-6,241,893 B1	06-2001	Levy, Ehud	210/660
*	E	US-5,772,896	06-1998	Denkewicz et al.	210/754
*	F	US-4,396,512	08-1983	Beauman et al.	210/668
*	G	US-6,057,262	05-2000	Derbyshire et al.	502/423
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.